

<b>Notice of References Cited</b>	Application/Control No. 10/587,807	Applicant(s)/Patent Under Reexamination MIYATA ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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**FOREIGN PATENT DOCUMENTS**

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	N	JP 2002-105604	04-2002	Japan	Kimura et al.	C22C 38/00
	O	EP 1026273	08-2000	EPO	Ueda et al.	C22C 38/00
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**NON-PATENT DOCUMENTS**

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